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electronic synapse from functionalized nanoparticle ink**

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# Towards fully printed memristive elements: a-TiO<sub>2</sub> electronic synapse from functionalized nanoparticle ink

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## ABSTRACT

Electronic devices that emulate bio-functionalities, such as synaptic plasticity, present a promising route to versatile and energy-efficient neuromorphic computing systems. As the demand for rapid-prototyping and environmentally-friendly fabrication of such devices rises, there are significant incentives toward finding solutions for low cost materials and flexible

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3 deposition techniques. The development of printed electronic devices is still at an infant stage,  
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5 presenting a timely opportunity to investigate material robustness and routes to overcoming  
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7 fabrication obstacles towards fully printed electronic synapses. In this work, a low power, fully  
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9 printed Ag (200 nm)/a-TiO<sub>2</sub>(80 nm)/Ag (160 nm) memristive device is demonstrated. The first  
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11 electrical characterization of early devices exhibits biomimetic properties with an indication of  
12  
13 activity-dependent plasticity. The active material is derived from a simplified nanoparticle ink  
14  
15 formulation developed in-house. The ink characterization confirms that the formulation fulfils  
16  
17 the criteria for efficient jetting while exhibiting a dwell time of 4 months. Additionally, the  
18  
19 common detrimental fabrication issues of layer cracks and control over uniformity here are  
20  
21 both overcome. The ink optimization and the investigation of the electrical framework under  
22  
23 which the memristive element responds synaptically present a favorable approach to  
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25 alternative fabrication methods for future neuromorphic electronics.  
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34 KEYWORDS: printed; electronics; memristive; a-TiO<sub>2</sub> ink formulation; artificial synapse  
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## 39 INTRODUCTION 40

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42 The brain is one of the most functionally complex and resource efficient organs in the human  
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44 body. The source of the brain's dexterity is primarily based on its synaptic functionalities; a  
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46 wondrous and far from fully-explored area. In neuroscience it is widely accepted that the  
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48 synaptic efficacy, or synaptic strength ( $w$ ), that controls a neuron's firing conditions, is critical  
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50 for signal communication and information processing. It governs the neuronal activity through  
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52 excitation or inhibition of the post-synaptic potential,<sup>1</sup> thus is vital for memory functions and  
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3 consequently for learning.<sup>2</sup> The key feature of interest of the synaptic strength is its plastic  
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5 variation, in other words its activity-dependent variation over time.<sup>3</sup> In more detail, the  
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7 stimulation of a synapse by a train of impulses results in a long-term or short-term modification  
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9 of the synaptic strength depending on both the timing of the trigger arrival and the rate of  
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11 stimulation. Tetanic stimulation (persistent stimuli of high rate) tends to produce a high rate of  
12  
13 substance transmission (neurotransmitters and proteins)<sup>3</sup> that typically results into long-term  
14  
15 potentiation/depression (LTP/LTD).<sup>4</sup> Longer time intervals between the trigger impulses,  
16  
17 however, leave time for the synapse to transition to its relaxation state and result in short-term  
18  
19 potentiation/depression (STP/STD).<sup>5,6</sup> It is also worth noting that, in cases of elevated  
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21 excitability or chronic depression, homeostatic plasticity takes place to retain stability and to  
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23 prevent the synapse from breakdown.<sup>7</sup>  
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31 To date, minimally structured electronic devices such as memristive elements<sup>8,9</sup> that emulate  
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33 real synapses are the most suitable candidates for versatile and power-efficient computing  
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35 paradigms. The imitation of these pivotal functionalities presents a major challenge today in the  
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37 field of neuromorphic computing. In the last decades, memristive devices that are based on  
38  
39 metal oxides have gathered much attention due to CMOS technology compatibility<sup>10,11</sup> and to  
40  
41 their biomimetic switching characteristics.<sup>12</sup> One of the most well-studied active materials with  
42  
43 reported memristive behavior in solid-state thin films is titanium dioxide (TiO<sub>2</sub>).<sup>13</sup> However, its  
44  
45 crystalline (c-TiO<sub>2</sub>) forms: anatase, brookite, rutile<sup>14</sup> are mainly deposited by physical vapor  
46  
47 deposition (PVD) or atomic layer deposition (ALD) at temperatures over 400 °C.<sup>15</sup> These  
48  
49 techniques are lacking in both energy and cost efficiency. In contrast, the amorphous TiO<sub>2</sub> (a-  
50  
51 TiO<sub>2</sub>) can be formed at lower temperatures, below 150 °C.<sup>16–18</sup> This enables TiO<sub>2</sub> deposition  
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3 through solution-based techniques of lower complexity. Attempts have been made at  
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5 fabricating bio-inspired electronic devices through low-cost fabrication techniques that are  
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7 mainly based on spin-coating and drop-casting.<sup>19–21</sup> Unfortunately, these techniques lack  
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9 control of areal uniformity and they usually require a separate additive and/or subtractive  
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11 fabrication step.<sup>22,23</sup>  
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16 Recently, much attention is focused on inkjet printing (IJP), which is a candidate for the most  
17  
18 promising unconventional fabrication method. The IJP technology aids the burgeoning field of  
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20 flexible electronics to expand and progress. This additive fabrication technique is one of the  
21  
22 most advantageous solution-processed based methods due to rapid prototyping capability, low  
23  
24 material waste<sup>24</sup> and potential 3D patterning. IJP is a technique of lower cost and lower  
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26 ecological impact compared to photolithography-based process, mainly due to the absence of  
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28 material-etching chemicals. It is a non-contact technique and masks are not required. Within  
29  
30 IJP, the least material-consuming and most commonly used operation mode is the drop on  
31  
32 demand (DoD).<sup>25</sup> During DoD, a driving voltage in the form of pulsed signals is applied to the  
33  
34 cartridge that is filled with the solution-ink. In this way, piezo-electrically induced drop ejection  
35  
36 takes place and a small amount of individual ink droplets, in the order of picolitres, are  
37  
38 deposited on the target substrate. The deposition and patterning are under direct computer  
39  
40 control. Additionally, IJP deposition on a wide range of substrates<sup>24</sup> is feasible due to low  
41  
42 temperature treatment and the option of rheology tuning through ink formulation. However,  
43  
44 the adjustment of fluid rheology is not a predefined process and varies significantly depending  
45  
46 on the active material. Features such as consistency and robustness in terms of rheological fluid  
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48 characteristics are also far from established and ink related physics and chemistry remain key  
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3 challenges today.<sup>26</sup> Consequently, to advance to the state of manufacturing functional printed  
4 devices with an acceptable yield, the jetting and practical fabrication obstacles of IJP, along with  
5 ink durability, require addressing. The present work is concentrated on the investigation of  
6 these critical parameters in solution-processed a-TiO<sub>2</sub>.  
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14 One of the most common fabrication drawbacks of solution-based TiO<sub>2</sub> is the development of  
15 cracks that subsequently result in leakage currents, and consequently to device failure.<sup>19,27</sup> To  
16 our knowledge, even though research has been carried out to overcome this limitation,<sup>28</sup> none  
17 is concerned with a-TiO<sub>2</sub> nanolayers that meet the IJP fabrication requirements for memristive  
18 elements. Additionally, reports on solution rheology and jetting characteristics are scarce,  
19 especially where related to ink formulation that maintains the key parameters within the  
20 specifications for the given IJP system.  
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32 In this project, Ag/a-TiO<sub>2</sub>/Ag memristive devices with ~ 90 μm x 100 μm active area and  
33 nanoscale thickness are developed through DoD IJP using a functionalized ink developed and  
34 optimized in-house. The solution-ink is fully characterized, in terms of nanoparticle and Z  
35 number (viscosity, surface tension, density) determination, values that enclose vital information  
36 on jettability. The pH of the ink is not investigated here as it has minimal influence in DoD  
37 jetting performance.<sup>26</sup> The outcomes are within the acceptable range for effective printing and  
38 the final device is crack-free with well coverage and cell-to-cell thickness uniformity. Electrical  
39 characterization is conducted on early devices and the results indicate that both short-term and  
40 long-term potentiation with trigger timing-dependent characteristics are potentially feasible  
41 with the developed, fully-printed devices.  
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### *Electrical characteristics of TiO<sub>2</sub>*

From the electrical perspective, memristive devices based on c-TiO<sub>2</sub> require an initial electroforming step in order to facilitate resistive switching (RS).<sup>29,30</sup> During electroforming, a high voltage is applied to the anode of the pristine c-TiO<sub>2</sub> device, breaking its crystal structure in a controlled manner and causing the creation and movement of oxygen vacancies (V<sub>o</sub>) within the active layer,<sup>29</sup> and notably their arrangement into a conductive bridge<sup>18,30</sup> (an oxygen deficient interconnection)<sup>31</sup> across the electrodes, that consequently shifts the device from a high resistance state (HRS) to a low resistance state (LRS). Conversely, in devices based on a-TiO<sub>2</sub>, the high electroforming voltages are not for resistive switching (RS) induction.<sup>32</sup> The RS does not emanate from a predefined pattern in this case due to the amorphous phase, but it is prone to more spontaneous state transitions. This probabilistic behavior could be suppressed through V<sub>o</sub> doping control, a promising but laborious option.<sup>33,34</sup> Alternatively, the RS accuracy could be neglected and instead, the trend of the switching, in terms of event-driven variations in resistance, a characteristic that remains unaffected, could be exploited. Ultimately, the evolution of the resistive state (or the change in synaptic strength over time), is the feature that underpins both volatile (short-term) and non-volatile (long-term) memory functionality. The electrical framework that defines the trend of the switching should provide an insight into the underlying mechanism. Understanding it in depth is essential for the implementation of synaptic plasticity, which still requires significant investigation.

Electrical analysis of memristive devices usually entails performing current-voltage sweeps.<sup>8,13</sup>

Alternatively, a biomimetic approach could be followed by applying voltage pulses<sup>35</sup>, thus

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3 characterizing the device by its current response over time. In this report, an attempt is made  
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5 to understand and exploit the printed electronic synapse's behavior by keeping a constant  
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7 voltage pulse amplitude and varying its timing characteristics.  
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## 10 11 12 13 14 15 EXPERIMENTAL SECTION 16

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18 *Device Fabrication:* The samples consist of the following layers: polymer coating layer/Ag/a-TiO<sub>2</sub>  
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20 /Ag/Teflon fabricated on glass substrates. Before the deposition of the bottom electrode, the  
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22 substrates are cleaned with acetone, isopropanol and methanol followed by an ultrasonic bath  
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24 clean with acetone and final rinsing with acetone and isopropanol. They are dried off with a N<sub>2</sub>  
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26 blow gun. Devices are fabricated via a sequence of layer deposition from bottom to top. For the  
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28 bottom and top electrodes, in the first device, a Nanosilver ink is used (Ag NPs dispersed in  
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30 ethanol, Kunshan Hisense Electronics Co., Ltd), while in the second device, a silver nanoparticle  
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32 ink in hydrocarbon-based solution (NPS-JL, Harima Chemicals) was used. These were deposited  
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34 through inkjet printing (IJP) (Fujifilm Dimatix DMP-2800 series) and sintered on a hot plate at  
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36 120 °C for ~ 20 min. The active layer is deposited through Fujifilm Dimatix in first sample and  
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38 through a dispenser (Musashi Engineering ML-808GX) in second sample. In both cases, the  
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40 synthesized ink is used as the active material (see the following section). In Fujifilm Dimatix, for  
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42 all the printing steps DoD method and a single nozzle is used with a DMCLCP-11610 cartridge  
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44 (10pL nominal droplet volume). The printing frequency is set at 2.0 kHz for the active ink and 1  
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46 kHz for the Ag, and the cartridge temperature was set at 30 °C and 40 °C, respectively. In both  
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48 cases, the printed active layers are left in air, under ambient conditions, for 30 min before  
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3 annealing on a hot plate at 80 °C for 10 min in air. Finally, the active area of the devices are  
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5 encapsulated with Teflon (AF1600X, Dupont, Wilmington, DE, USA), dissolved in Fluorinert (FC-  
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7 43, 3M Company, Maplewood, MN, USA) to 1 wt%.<sup>36</sup> The final active area of first device is ~  
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9 150x90  $\mu\text{m}^2$  and of second ~ 150x180  $\mu\text{m}^2$ .  
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14 *Ink preparation/Formulation:* For synthesis, a capping agent is added (1 ml of glacial acetic acid,  
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16 HOAc) to the reaction matrix of (a) 1.26 ml of Ti (IV) isopropoxide (TTIP 97%, Sigma Aldrich),  
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18 which is employed as a trace metal basis for the synthesis and used as received, and (b) 10 ml  
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20 of 1-methoxy-2-propanol. After an overnight stirring in ambient conditions, the mixed  
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22 compound is ultrasonicated for 30 min and filtered through 2  $\mu\text{m}$  PTFE filter. For viscosity  
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24 adjustment, ethylene glycol ((CH<sub>2</sub>OH)<sub>2</sub>) is added (1:1 vol %), followed by 30 min stirring under  
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26 ambient conditions. In the first device, the jetting parameters of voltage and frequency are set  
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28 at 22 V and 2 Hz, respectively with a drop spacing set to 30  $\mu\text{m}$ . In the second device, a  
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30 dispenser is used with a  $\varnothing$  0.1 mm metal needle (brass with Ni plating) for the deposition. A  
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32 pressure of 10 kPa is used for droplet ejection. In both samples, the printing head and sample  
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34 holder temperatures are fixed at 30 °C.  
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42 *Materials Characterization:* The derived nanoparticle suspension-ink was characterized via  
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44 dynamic light scattering using the Zetasizer Nano ZSP (Malvern Instruments Ltd. UK). The mean  
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46 particle diameter and polydispersity index (PDI) are recorded. The measurements are  
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48 performed at 25 °C without any prior sample preparation. The ink viscosity is determined using  
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50 a DV3T Brookfield rheometer and the surface tension is measured on a Theta (Biolin Scientific)  
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52 instrument. The deposited active layers are analysed by XPS, on a K-Alpha + spectrometer  
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3 (ThermoFisher Scientific Instruments, East Grinstead, UK). XPS spectra are acquired using a  
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5 monochromated Al KaX-ray source ( $h\nu=1.486,6$  eV) with an X-ray spot of  $\sim 400$   $\mu\text{m}$  radius.

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8 Survey spectra are acquired employing a Pass Energy of 200 eV. High resolution, core level  
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10 spectra for all elements are acquired with a Pass Energy of 50 eV. All spectra are charge-  
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12 referenced against the C1s peak at 285 eV to correct for charging effects during acquisition.

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15 Quantitative surface chemical analyses are calculated from the high resolution, core level  
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17 spectra following the removal of a non-linear (Shirley) background. The manufacturer's  
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19 Advantage software is used, which incorporates the appropriate sensitivity factors and corrects  
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21 for the electron energy analyzer transmission function.  
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26 The morphology of the resulting layers is characterized using a Dektak XT (Bruker) profilometer  
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28 and cross-section Scanning Electron Microscopy (SEM). The cross-section microscopy is  
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30 conducted with a FEI Nova Nanolab and images are taken with a Tescan FERA3 Dual Beam for  
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32 layer uniformity and thickness characterization. Before the milling process, using the Ga<sup>+</sup> beam,  
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34 Pt protective layers are deposited, assisted by electron (Pt-EBID, beam characteristics: 5keV and  
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36 0.4 nA) and ion (Pt-IBID, beam characteristics: 30 keV and 0.3 nA) beams. Cross-sections were  
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38 then performed with the Ga<sup>+</sup> beam (30 keV, 0.50 nA).  
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44 *Electrical Characterization:* The I-t measurements are conducted by using a Keithley 4200-SCS  
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46 semiconductor parameter analyzer and a Wentworth probe station. For all the measurements,  
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48 the top Ag electrode is biased, while the bottom Ag electrode is grounded, unless otherwise  
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50 specified. The compliance current was set to 10 mA. The amplitude of voltage input steps was  
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52 fixed at +1V and the pulse durations for each case can be found in the main text.  
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## RESULTS AND DISCUSSION

### *Active Ink Characterization*

The in-house formulated ink-solution for the active layer is based on Ti (IV) isopropoxide and 1-methoxy-2-propanol as the main solvent using a simplified combination of the sol-gel<sup>37</sup> and the Pechini methods<sup>38</sup> that does not incorporate an aqueous precursor or require a high temperature (see Experimental Section), unlike processes used elsewhere.<sup>16,22,39,40</sup>

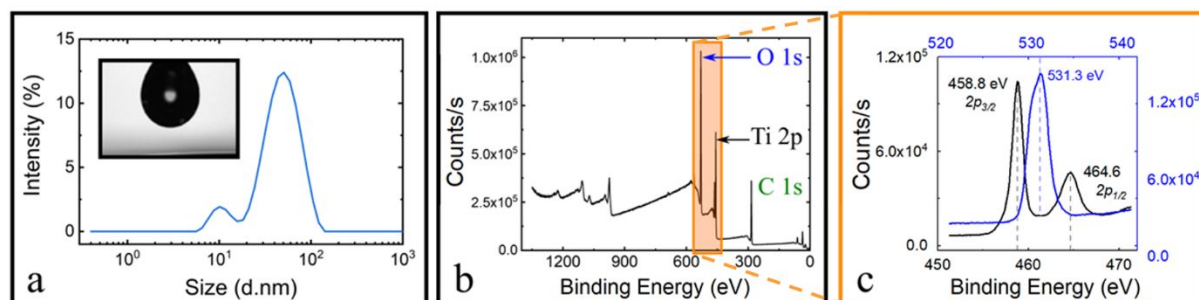
The nanoparticle ink is characterized through dynamic light scattering (DLS). The measurement shows that the nanoparticles are mostly within a relatively narrow size distribution around 36 nm in diameter with some smaller, in the range of 10 nm (**Figure 1a**). The Z number is calculated to be approximately 2.9, according to the equation<sup>41</sup>:

$$Z = \frac{(\alpha \cdot \rho \cdot \gamma)^{\frac{1}{2}}}{\eta}$$

where,  $\alpha$  is the diameter of the printing orifice (here, 21.5  $\mu\text{m}$ ),  $\rho$  is the ink density ( $\sim 1070 \text{ kg/m}^3$ ),  $\gamma$  is its surface tension ( $\sim 32 \text{ mN/m}$ ) and  $\eta$  is its viscosity ( $\sim 9 \text{ mPa s}$ ). The resulting Z value falls well within the jettability range of 1 to 10.<sup>42,43</sup> Values smaller than 1 indicate high viscosity with low jetting probability, while values larger than 10 indicate low viscosity and can result in uncontrollable spontaneous jetting.

An X-ray photoelectron spectroscopy (XPS) measurement is performed to analyse the chemical composition of the deposited active film after its annealing. The results show a binding energy at 458.79 eV (15.34 %), which is attributed to the core level Ti 2p<sub>3/2</sub> of Ti<sup>4+</sup> state (**Figure 1b**).<sup>44,45</sup>

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3 These findings correlate with the existing reports on sol-gel a-TiO<sub>2</sub> films.<sup>44,46,47</sup> It should be  
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5 noted that the samples are annealed at significantly lower temperatures (~ 80 °C) compared to  
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7 those required for crystalline TiO<sub>2</sub>,<sup>45</sup> thus the most favorable phase here for TiO<sub>2</sub> is the  
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9 amorphous one. The XPS survey (see **Table S1**, for the concentration of the elements in  
10  
11 Supporting Information) shows the presence of carbon (C 1s peak at 284.8 eV) which arises due  
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13 to adventitious carbon (C-C), thus is not correlated with the composition of the developed  
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15 nanoparticles. The C-C contamination is expected as the sample was not cleaned or otherwise  
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17 prepared before the XPS measurement. Apart from the minor concentration (0.43 %) of  
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19 fluorine (F, at 689.32 eV), other elements are not apparent.  
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38 **Figure 1.** a) DLS measurements of 1-methoxy-2-propanol-based Ink. The graph presents the  
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40 mean value of nanoparticles diameter (nm). The inset shows the respective droplets during  
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42 surface tension measurements. b) XPS Survey of the a-TiO<sub>2</sub> active layer and c) the  
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44 corresponding Ti<sub>2p</sub> (black) and O<sub>1s</sub> scan (blue) (the graphs are presented separately in  
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46 Supporting Information **Figure S2**).  
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51 In this work, the synthesis takes place under ambient conditions, and does not require an  
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53 autoclave and H<sub>2</sub>O insertion, a process believed to cause nanoparticle agglomeration.<sup>48</sup> The  
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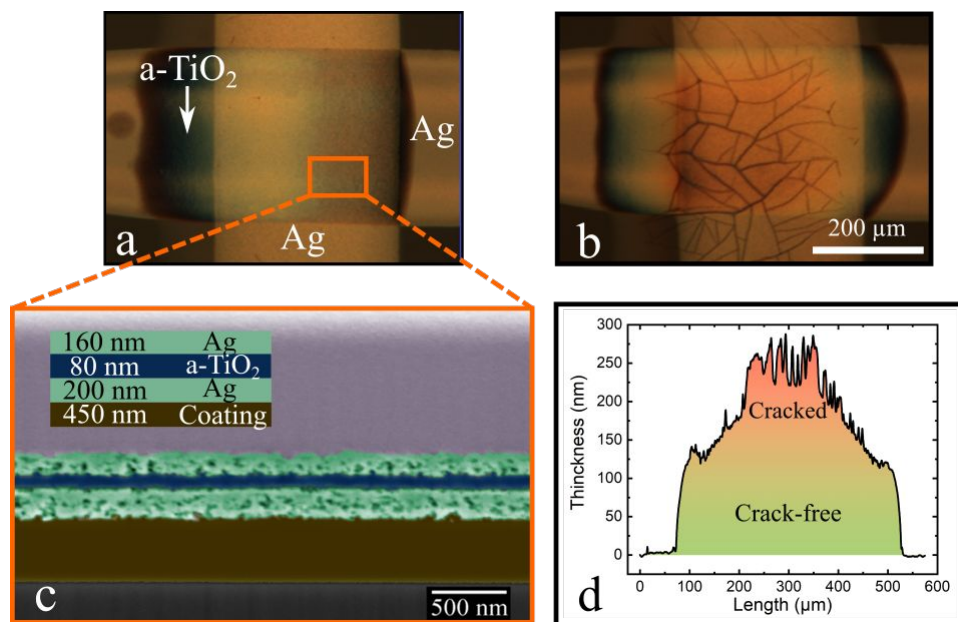
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3 addition of ethylene glycol as a second solvent induces the enhancement of nanoparticle  
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5 dispersion and the reduction of agglomerations. The presence of nanoparticle agglomerations  
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7 often leads to a skinning effect during ink ejection (the formation of crust on the cartridge head  
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9 surface) that results in clogging of the nozzles. The same property of improved dispersion can  
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11 also be observed in 2-propanol-based ink, by following the same synthesis (see **Figure S1** in  
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13 Supporting Information). Additionally, the high boiling points of 1-methoxy-2-propanol and  
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15 ethylene glycol (190 °C and 120 °C respectively) result in slower evaporation rate than in the  
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17 case of 2-propanol and ethanol,<sup>49</sup> further mitigating the probability of the skinning effect. When  
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19 synthesis follows recipes from literature, it produces an unstable solution with a presumably  
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21 incomplete reaction which leads to nozzles clogging after a few uses, limiting cartridge lifetime  
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23 and making jetting unreliable. However, in the present work, the functionalized ink developed  
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25 in-house does not lead to notable clogging, extending considerably its lifetime to four months.  
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27 Additionally, the derived film presents an amorphous nature with minimum residual elements.  
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29 While it should be noted that limited reports exist on inks durability, as the inkjet printing is still  
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31 in an infant stage,<sup>50</sup> the present work demonstrates promising results towards enabling the  
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33 inkjet printing as an efficient and flexible alternative fabrication method for printed memristive  
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35 devices.  
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#### 46 *Layer Characterization*

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49 After the sequential deposition and treatment of the layers (see Experimental Section), the  
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51 active area of the Ag/a-TiO<sub>2</sub>/Ag device is characterized. **Figure 2a** and **Figure 2b** show the active  
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53 areas of two devices that differ in active layer thickness. Notably, when the thickness of the  
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3 resulting a-TiO<sub>2</sub> film is within the range of 50 to 120 nm, it is mainly crack-free (**Figure 2a**).  
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5 However, when the active layer is thicker than 120 nm the incidence of fissure formation, and  
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7 consequent damage to the device, increases significantly. These cracks and deformations are  
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9 also evident in the Ag top layer (**Figure 2b**). **Figure 2c** presents the cross-section SEM image of a  
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11 printed device, the layers of which have been deposited on a polymer-coated conductive Si (p-  
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13 doped wafer substrate) for the purpose of SEM imaging. The printed layers and their  
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15 thicknesses are shown in the inset of **Figure 2c**, and the Pt-EBID and Pt-IBID protective layers  
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17 are depicted in purple. The Ag layers present porous areas that do not seem to deteriorate the  
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19 electrical properties in the present application. The active a-TiO<sub>2</sub> layer appears denser and, in  
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21 general, the printed films are uniform and homogeneously spread on the substrate. **Figure 2d**  
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23 depicts the relation between layer thickness and prevalence of cracks observed in all of the  
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25 developed devices. When the thickness of the active layer is below 120 nm (green area of  
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27 Figure 2d) doesn't appear to have any cracks, however in higher thicknesses between 120 nm-  
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29 150 nm (green – orange area), the layer starts to deform and finally generate fissures at  
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31 thicknesses over 150 nm ('spikes' in orange area). Here, the temperature does not appear to  
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33 promote the formation or healing of cracks and they are solely thickness dependent, as, even  
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35 when annealed at higher temperatures (130-200 °C) and for longer (2 to 3 hours), active layer  
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37 morphology was largely unaltered.  
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**Figure 2.** Micrographs of printed polymer coating/Ag/a-TiO<sub>2</sub>/Ag devices on glass without (a) and with cracks (b). c) SEM cross-section view of device layers deposited on Si wafer. d) Profilometer results, present the relation between active layer thickness and cracks prevalence.

Overall, both active layer and electrode deposition, along with film formation are well-controlled through the inkjet printing process. This demonstrates that, the critical challenges of crack formation, layer thickness and areal uniformity, and cell-to-cell variability can be effectively managed in fully-printed device structures.

### *Electrical Characterization*

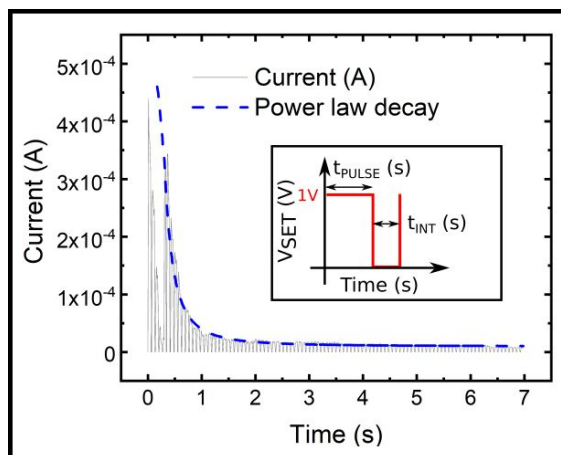
The switching characteristics are investigated by applying voltage pulse-trains to the device and measuring the current output over time. The trigger's timing characteristics of period  $T$  ( $t_{\text{pulse}} + t_{\text{int}}$ ) and duty cycle  $\alpha$  ( $t_{\text{pulse}} / T$ ) are altered, while the amplitude ( $V_{\text{set}}$ ) is fixed at +1 V for all the measurements (see **Figure 3** inset). A voltage withdrawal of 60 s ( $V_{\text{off}}$ ) follows a sequence of

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3 pulse-train in order to investigate the device's capability of resistance state retention. Here, the  
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5 measurements of *Pulse Train 1* ( $\alpha \sim 70\%$ ,  $T = 70$  ms) and *Pulse Train 2* ( $\alpha \sim 70\%$ ,  $T = 7$  ms) are  
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7 presented. Additional measurements can be found in the Supporting Information (Figure S5,  
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9 **Figure S6, Table S2**). The defining properties for a memristive device in terms of its plasticity is  
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11 how the output current evolves in relation to the history of events, in this case the pulse trigger  
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13 timing characteristics.  
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18 Initially, *Pulse Train 1* is applied to the device under ambient conditions. **Figure 3** depicts the  
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20 switching characteristics of the pristine device. An abrupt increase in current takes place, that  
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22 reaches  $\sim 4.5 \times 10^{-4}$  A, followed by a steep and then slow decrease. The observed current  
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24 overshoot presents spike-like behavior that can be described as analogous to the biological  
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26 synapse's power-law decay of calcium concentration ( $\text{Ca}^{2+}$ ).<sup>6,51,52</sup> Here, the decay constant  $\tau$  is  
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28 approximately 0.5 s. In biological synapses it is often observed that during tetanus (persistent  
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30 stimuli - train of impulses), the transmission of substances rise briefly due to facilitation before  
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32 a depression takes place.<sup>53</sup> The depression on initial stage of transmission suggests that it is due  
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34 to limited store of releasable neurotransmitter (that likely reflects a depletion of a release-  
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36 ready pool of vesicles) which is exhausted and not instantaneously replenish. It is believed that  
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38 the most easily released quanta are secreted first, while those remaining are less easily  
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40 released.<sup>54,55</sup> In general, a decline in post-synaptic current amplitude during repeated  
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42 stimulation usually is observed, that takes seconds to minutes to recover after stimulation.<sup>56</sup> In  
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44 c-TiO<sub>2</sub> during the initial electroforming step, a current decay is mainly observed that usually  
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46 implies heat generation and is believed to be attributed to the formation of a conductive  
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48 path.<sup>57-59</sup> The present observation lead us to assume that a type of electroforming still occurs in  
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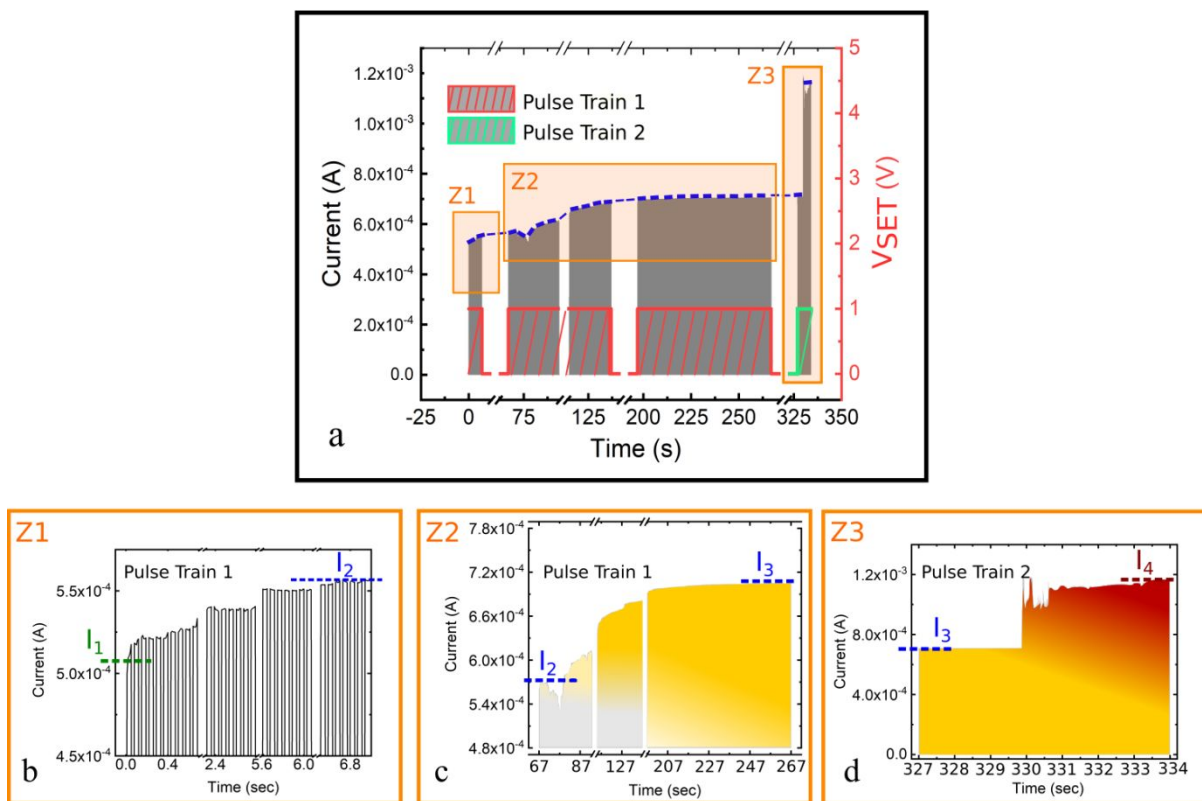


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3 amorphous phase. This could be ascribed to the development of an intrinsic thermal effect that  
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5 builds up during the initial voltage application.<sup>60</sup>  
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25 **Figure 2.** Initial current overshoot of the pristine device under *Pulse Train 1*. Inset: Schematic of  
26 pulse trigger timing.  
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30 After the current outbreak, the device returns to the high resistance state without showing  
31 further conductive characteristics with the given input characteristics. To further investigate the  
32 thermal effect on the switching, a temperature of 100 °C is applied to the substrate holder  
33 during the remaining electrical measurements of the first device. **Figure 4a** shows the evolution  
34 of current over time under *Pulse Train 1* and *Pulse Train 2* including the intermediate 60 s  
35 voltage interruptions ( $V_{\text{off}}$ ) that are presented as breaks in the time axis (the original graph can  
36 be found in Supporting Information, **Figure S3**). From the observation of the electrical  
37 measurements (**Figure 4a**), it can be stated that the device retains its resistance state after  $V_{\text{off}}$ ,  
38 thus indicating long-term potentiation (LTP).  
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**Figure 3.** Electrical characterization under 100 °C during *Pulse Train 1* & *Pulse Train 2* triggers. a) Evolution of current over time. b-d) The areas of interest Z1-Z3 of graph (a).

At first, under 100 °C, in the Z1 area of interest in **Figure 4a**, the *Pulse Train 1* is applied for 7 s followed by a  $V_{\text{off}}$ . In **Figure 4b** it can be seen that a soft, step-wise increase in current by  $\sim 0.57 \times 10^{-4}$  A (approx. 10%) occurs and reaches  $5.57 \times 10^{-4}$  A ( $I_2$ ) (For the full graph see Supporting Information, **Figure S4**). Next, in the Z2 period, the same stimulus continues for a longer period of 200 s. The subsequent current output and intermediate  $V_{\text{off}}$ , are presented in **Figure 4c**. Initially, the current takes 30 s and then 40 s to increase total by  $0.57 \times 10^{-4}$  A, the same amount as in the primary Z1 case. Finally, it takes more than 60 s to rise by just 50 % of the initial state and reach  $\sim 7 \times 10^{-4}$  A ( $I_3$ ). This observation implies that after the first current increase in Z1 ( $I_2$ ), a

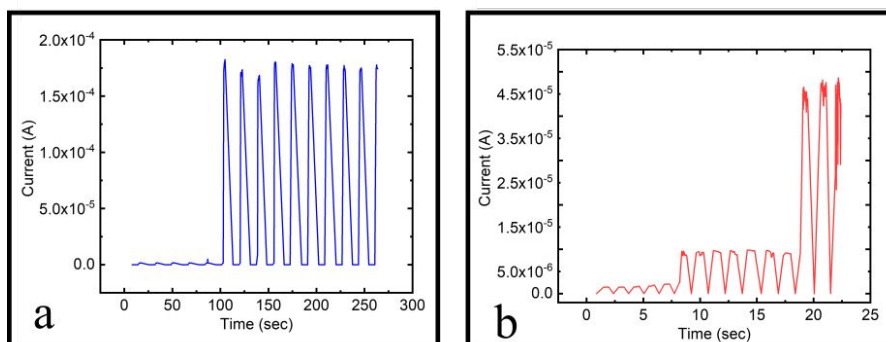
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3 longer time is required for further augmentation by the same amount. Notably, this is a  
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5 considerable biomimetic attribute. According to Bi et al.,<sup>61</sup> a significant long-term potentiation  
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7 (LTP) can be achieved only in synapses with low initial strength, consequently affecting the  
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9 evolution of the synaptic strength in a non-linear manner, an effect that is usually referred as  
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11 “metaplasticity”.<sup>62</sup> In both biological synapses and in the present electronic synapse, the  
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13 susceptibility to potentiation is strongly affected by the initial strength or, in other words, the  
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15 primary resistance state. The lower the resistance state, the greater the potentiation that can  
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17 be achieved with a given trigger. After the highest current state (in this case,  $I_3$  in Z2 area) is  
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19 reached, it seems to be sustained regardless of trigger duration. Thus, further change under the  
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21 same applied stimulus cannot be induced.  
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28 Next, after the last  $V_{off}$ , *Pulse Train 2* is applied. The measurement results in **Figure 4d** show  
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30 that the  $I_3$  current state of  $\sim 7 \times 10^{-4}$  A persists for approximately 3 s and then grows sharply by  
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32  $3 \times 10^{-4}$  A, and finally expands to  $11.6 \times 10^{-4}$  A after 7 s ( $I_4$  in Z3 area, **Figure 4d**). Here, the shorter  
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34 trigger period of *Pulse Train 2* prompts a significant current enhanced. From the current  
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36 observations it can be stated that during the application of *Pulse Train 1*, the resistance state  
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38 alters in a slow and step-wise manner until reaching its maximum for the given trigger ( $I_3$ ).  
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40 However, during *Pulse Train 2*, where tetanic stimulation is applied, the rate of resistance  
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42 change is considerably affected, enabling further potentiation in an abrupt, hard switching  
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44 manner.  
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51 Notably, when  $t_{int}$  is equal to  $t_{pulse}$  ( $\alpha = 50\%$ ) a reduction in current is observed, with a shorter T  
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53 again inducing a higher rate of change (see in Supporting Information, **Figure S6**, and **Table S2**).  
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In this case of a smaller duty cycle, the device recovers from the tetanic stimulation and passes to its relaxation state, consequently the potentiation is hindered. This is comparable to biological synaptic inhibition.<sup>63</sup>

From the electrical characterization, it could be inferred that an additional intrinsic thermal effect may play a driving role in the rate of switching. The following electrical characterization of the second device (see Experimental Section) which is tested under ambient conditions ( $\sim 25\text{ }^\circ\text{C}$ ) further reinforces this argument. In the second device, initially a  $V_{\text{set}}$  of  $\alpha = 78\%$  with  $T = 8\text{ s}$  is applied. As **Figure 5a** shows, the output current rises by two orders of magnitude after  $\sim 100\text{ s}$  of stimulation. After the  $60\text{ s } V_{\text{off}}$ ,  $\alpha$  is decreased to  $55\%$  and  $T$  to  $1\text{ s}$ . **Figure 5b** shows that the current is augmented by one order of magnitude within  $7\text{ s}$ , with a further five-fold increase after  $10\text{ s}$ .



**Figure 5.** Second device electrical characterization in room temperature under pulse train trigger of: a)  $\alpha = 78\%$  and  $T = 8\text{ s}$ , and after  $60\text{ s } V_{\text{off}}$  under b)  $\alpha = 55\%$  and  $T = 1\text{ s}$

These results indicate both a switching behavior with discernible intermediate states (soft switching), and with longer  $t_{\text{pulse}}$ , a strong facilitation with abrupt increase (hard switching). In

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3 contrast with the first device, after  $V_{\text{off}}$ , the current do not remain on the same level but  
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6 reclaims its initial minimum state of  $\sim 1.5 \times 10^{-6}$  A. Thus, in this case where external heating is  
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8 not applied, the device's response follows the electrical frame of short-term potentiation  
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10 (STP).<sup>64</sup>  
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14 To summarize, the synaptic efficacy ( $w$ ) or resistance state, in the present printed Ag/a-TiO<sub>2</sub>/Ag  
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16 devices is strongly affected by the period ( $T$ ) of the trigger stimuli and the duration of the  
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18 trigger pulse ( $t_{\text{pulse}}$ ) in relation to the interpulse time ( $t_{\text{int}}$ ). By keeping the voltage amplitude  
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20 constant at +1V and altering the pulse timing characteristics, transitions to different resistance  
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22 states can be achieved in an event-driven manner. Tetanic stimulation seems to affect the  
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24 electronic synapse in the same way as in biological systems. In the case of LTP, the switching  
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26 threshold is dependent on the prior stimuli applied, an observation that indicates  
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28 commonalities with the non-linear effect of metaplasticity. Both potentiation and depression  
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30 (see Supporting Information, **Figure S6**) within a single memristive unit cell, are demonstrated  
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32 as potentially feasible in fully printed a-TiO<sub>2</sub> electronic synapses. In general, the present  
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34 findings indicate an activity-dependent modulation of the resistance state with notable  
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36 biomimetic characteristics.<sup>61,65</sup> Coexistence of both potentiation and depression attributes in a  
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38 single electronic element enables power efficient electronic systems with brain-inspired and  
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40 even cognitive functionalities.  
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49 Due to the amorphous nature of the derived active layer, the determination of the synapses'  
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51 underlying switching mechanism is not straightforward. Even in the case of well-known  
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53 crystalline forms of TiO<sub>2</sub>, the exact nature of the switching still constitutes ongoing research.  
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3 Here, the most suitable explanation of the conduction is its correlation with the presence of  
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5 ionic defects, such as impurities, Ti interstitials and  $V_o$ . The neutral  $V_o$  are deep donors in a-  
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7  $TiO_2$ .<sup>32</sup> and in the present devices the vacancies are abundant, as can be derived from XPS  
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9 results. The initial behaviour in Figure 3 could be connected to the movement of the existing  
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11 electrons. In which case the applied electric field is not enough to stimulate the  $V_o$  that instead  
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13 might act as trapping centres<sup>66</sup> and induce the current decay. The electrical behavior under high  
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15 temperature is more possibly attributed to ionic movements (in this case  $V_o$ ) that are likely  
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17 becoming more mobile than cations<sup>67</sup> and control the switching, inducing LTP (Figure 4). Both  
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19 intrinsic (with tetanic or strong stimulation) and extrinsic (with external heating) thermal effects  
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21 seem to influence the switching considerably.  
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## 30 CONCLUSIONS

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33 A low-cost electronic synapse with low electroforming voltage and event-driven attributes is  
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35 realized by implementing minimal synthesis and a fully additive fabrication process. Device  
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37 current output is controlled through trigger pulse rate and pulse - interpulse durations, while  
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39 the amplitude remains at the low level of +1 V. Long-term and short-term potentiation in a  
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41 single printed cell appear to be possible, enabling versatile operations. An indication of synaptic  
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43 depression is also observed, suggesting complete bio-emulation. Devices are fabricated by  
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45 implementing an a- $TiO_2$  nanoparticle ink developed in-house and optimized, overcoming  
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47 cracked layers and nozzle clogging, and considerably improving ink lifetime. Since active  
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49 material robustness has not been previously reported as a critical parameter for fabrication, we  
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51 can state that the printed memristive devices are still under incipient development and the  
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3 present work presents promising results towards fully printed memristive elements. Further  
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5 improvement of these minimally-structured memristive elements could result in efficient  
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7 flexible electronic synapses that provide a biomimetic versatile processing system within a  
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9 single printed unit cell.  
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## 12 13 14 ASSOCIATED CONTENT

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17 **Supporting Information.** The following files are available free of charge.

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19  
20 DLS results of EG-based ink, XPS analysis details and table of elements atomic concentrations,  
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22 Figure 4a and Figure 4b original graphs, Pulse Train 3 timing characteristics, electrical  
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24 characterization under Pulse Train 2 to 5, table of Pulse Trains timing characteristics (doc)  
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### 37 38 **Author Contributions**

39  
40 All authors contributed to the manuscript and have given approval to the final version.  
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### 49 50 **Notes**

51  
52 The authors declare no conflict of interest.  
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## REFERENCES

- (1) Bliss, T. V.; Collingridge, G. L. A Synaptic Model of Memory: Long-Term Potentiation in the Hippocampus. *Nature* **1993**, *361* (6407), 31–39. <https://doi.org/10.1038/361031a0>.
- (2) Bi, G. Q.; Poo, M. M. Distributed Synaptic Modification in Neural Networks Induced by Patterned Stimulation. *Nature* **1999**, *401* (6755), 792–796. <https://doi.org/10.1038/44573>.
- (3) Hennig, M. H. Theoretical Models of Synaptic Short Term Plasticity. *Front. Comput. Neurosci.* **2013**, *7*, 45. <https://doi.org/10.3389/fncom.2013.00045>.
- (4) Bliss, J. C.; Crane, H. D.; Mansfield, P. K.; Townsend, J. T. Information Available In Brief Tactile Presentations. *Percept. Psychophys.* **1966**, *1* (4), 273–283. <https://doi.org/10.3758/BF03207391>.
- (5) Zhang, W.; Li, H.; Yang, M.; Mesgarani, N. SYNAPTIC DEPRESSION IN DEEP NEURAL NETWORKS FOR SPEECH PROCESSING. *Proc. ... IEEE Int. Conf. Acoust. Speech, Signal Process. ICASSP* **2016**, *2016*, 5865–5869. <https://doi.org/10.1109/ICASSP.2016.7472802>.
- (6) Graupner, M.; Brunel, N. Calcium-Based Plasticity Model Explains Sensitivity of Synaptic Changes to Spike Pattern, Rate, and Dendritic Location. *Proc. Natl. Acad. Sci.* **2012**, *109*



- (10), 3991–3996. <https://doi.org/10.1073/pnas.1109359109>.
- (7) Vitureira, N.; Goda, Y. The Interplay between Hebbian and Homeostatic Synaptic Plasticity. *J. Cell Biol.* **2013**, *203* (2), 175–186. <https://doi.org/10.1083/jcb.201306030>.
- (8) Chua, L. Resistance Switching Memories Are Memristors. *Appl. Phys. A Mater. Sci. Process.* **2011**, *102* (4), 765–783. <https://doi.org/10.1007/s00339-011-6264-9>.
- (9) Chua, L. O. Memristor—The Missing Circuit Element. *IEEE Trans. Circuit Theory* **1971**, *18* (5), 507–519. <https://doi.org/10.1109/TCT.1971.1083337>.
- (10) Jameson, J. R.; Gilbert, N.; Koushan, F.; Saenz, J.; Wang, J.; Hollmer, S.; Kozicki, M. N. One-Dimensional Model of the Programming Kinetics of Conductive-Bridge Memory Cells. *Appl. Phys. Lett.* **2011**, *99* (6), 063506. <https://doi.org/10.1063/1.3623485>.
- (11) Russo, U.; Kamalanathan, D.; Ielmini, D.; Lacaíta, A. L.; Kozicki, M. N. Study of Multilevel Programming in Programmable Metallization Cell (PMC) Memory. *IEEE Trans. Electron Devices* **2009**, *56* (5), 1040–1047. <https://doi.org/10.1109/TED.2009.2016019>.
- (12) Indiveri, G.; Linares-Barranco, B.; Legenstein, R.; Deligeorgis, G.; Prodromakis, T. Integration of Nanoscale Memristor Synapses in Neuromorphic Computing Architectures. **2013**. <https://doi.org/10.1088/0957-4484/24/38/384010>.
- (13) Strukov, D. B.; Snider, G. S.; Stewart, D. R.; Williams, R. S. The Missing Memristor Found. *Nature* **2008**, *453* (7191), 80–83. <https://doi.org/10.1038/nature06932>.
- (14) Reyes-Coronado, D.; Rodríguez-Gattorno, G.; Espinosa-Pesqueira, M. E.; Cab, C.; De Coss, R.; Oskam, G. Phase-Pure TiO<sub>2</sub> Nanoparticles: Anatase, Brookite and Rutile. *Nanotechnology* **2008**, *19* (14). <https://doi.org/10.1088/0957-4484/19/14/145605>.
- (15) Mahshid, S. Synthesis of TiO<sub>2</sub> Nanoparticles by Hydrolysis and Peptization of Titanium

- 1  
2  
3 Isopropoxide Solution . *J Mater Process Technol* 9 : 65-68. **2007**, 189 (September 2015),  
4  
5 65–68. <https://doi.org/10.1016/j.jmatprotec.2007.01.040>.  
6  
7  
8 (16) Kim, J. Y.; Kim, S. H.; Lee, H. H.; Lee, K.; Ma, W.; Gong, X.; Heeger, A. J. New Architecture  
9  
10 for High-Efficiency Polymer Photovoltaic Cells Using Solution-Based Titanium Oxide as an  
11  
12 Optical Spacer. *Adv. Mater.* **2006**, 18 (5), 572–576.  
13  
14 <https://doi.org/10.1002/adma.200501825>.  
15  
16  
17 (17) Mitra, A.; De, G. Sol-Gel Synthesis of Metal Nanoparticle Incorporated Oxide Films on  
18  
19 Glass. *Glas. Nanocomposites Synth. Prop. Appl.* **2016**, 145–163.  
20  
21 <https://doi.org/10.1016/B978-0-323-39309-6.00006-7>.  
22  
23  
24 (18) Acharyya, D.; Hazra, A.; Bhattacharyya, P. A Journey towards Reliability Improvement of  
25  
26 TiO<sub>2</sub>based Resistive Random Access Memory: A Review. *Microelectron. Reliab.* **2014**, 54  
27  
28 (3), 541–560. <https://doi.org/10.1016/j.microrel.2013.11.013>.  
29  
30  
31 (19) Park, S.; Kim, C. H.; Lee, W. J.; Sung, S.; Yoon, M. H. Sol-Gel Metal Oxide Dielectrics for  
32  
33 All-Solution-Processed Electronics. *Mater. Sci. Eng. R Reports* **2017**, 114, 1–22.  
34  
35 <https://doi.org/10.1016/j.mser.2017.01.003>.  
36  
37  
38 (20) Kaltenbrunner, M.; Sekitani, T.; Reeder, J.; Yokota, T.; Kuribara, K.; Tokuhara, T.; Drack,  
39  
40 M.; Schwödiauer, R.; Graz, I.; Bauer-Gogonea, S.; Bauer, S.; Someya, T.; Schwö, R. An  
41  
42 Ultra-Lightweight Design for Imperceptible Plastic Electronics. *Nature* **2013**, 499 (7459),  
43  
44 458–463. <https://doi.org/10.1038/nature12314>.  
45  
46  
47 (21) Gale, E.; Pearson, D.; Kitson, S.; Adamatzky, A.; De Lacy Costello, B. The Effect of  
48  
49 Changing Electrode Metal on Solution-Processed Flexible Titanium Dioxide Memristors.  
50  
51 *Mater. Chem. Phys.* **2015**, 162, 20–30.  
52  
53  
54  
55  
56  
57  
58  
59  
60

- 1  
2  
3 <https://doi.org/10.1016/j.matchemphys.2015.03.037>.
- 4  
5  
6 (22) Gale, E.; Pearson, D.; Kitson, S.; Adamatzky, A.; De Lacy Costello, B. Aluminum Electrodes  
7  
8 Effect the Operation of Titanium Oxide Sol-Gel MR. *Mater. Chem. Phys.* **2015**, *162* (May),  
9  
10 20–30. <https://doi.org/10.1016/j.matchemphys.2015.03.037>.
- 11  
12  
13 (23) Vilmi, P.; Nelo, M.; Voutilainen, J.-V.; Palosaari, J.; Pörhönen, J.; Tuukkanen, S.; Jantunen,  
14  
15 H.; Juuti, J.; Fabritius, T. Fully Printed Memristors for a Self-Sustainable Recorder of  
16  
17 Mechanical Energy. *Flex. Print. Electron.* **2016**, *1* (2), 025002.  
18  
19  
20 <https://doi.org/10.1088/2058-8585/1/2/025002>.
- 21  
22  
23 (24) Bhore, S. S. Formulation and Evaluation of Resistive Inks for Applications in Printed  
24  
25 Electronics. **2013**, 1–94. <https://doi.org/10.1002/adma.201101328>.
- 26  
27  
28 (25) Nallan, H. C.; Sadie, J. A.; Kitsomboonloha, R.; Volkman, S. K.; Subramanian, V. Systematic  
29  
30 Design of Jettable Nanoparticle-Based Inkjet Inks: Rheology, Acoustics, and Jettability.  
31  
32 *Langmuir* **2014**, *30* (44), 13470–13477. <https://doi.org/10.1021/la502903y>.
- 33  
34  
35 (26) Tuladhar, T. Measurement of Complex Rheology and Jettability of Inkjet Inks. In  
36  
37 *Handbook of Industrial Inkjet Printing: A Full System Approach*; Zapka, W., Ed.; Wiley-VCH  
38  
39 Verlag GmbH & Co. KGaA., 2017; pp 409–431.
- 40  
41  
42 (27) Chen, X.; Mao, S. S. Titanium Dioxide Nanomaterials: Synthesis, Properties, Modifications  
43  
44 and Applications. *Chem. Rev.* **2007**, *107* (7), 2891–2959.  
45  
46  
47 <https://doi.org/10.1021/cr0500535>.
- 48  
49  
50 (28) Nagpal, V. J.; Davis, R. M.; Desu, S. B. Novel Thin Films of Titanium Dioxide Particles  
51  
52 Synthesized by a Sol-Gel Process. *J. Mater. Res.* **2011**, *10* (12), 3068–3078.  
53  
54  
55 <https://doi.org/10.1557/JMR.1995.3068>.
- 56  
57  
58  
59  
60

- 1  
2  
3 (29) Savel'ev, S. E.; Alexandrov, A. S.; Bratkovsky, A. M.; Stanley Williams, R. Molecular  
4 Dynamics Simulations of Oxide Memory Resistors (Memristors). *Nanotechnology* **2011**,  
5 22 (25), 254011. <https://doi.org/10.1088/0957-4484/22/25/254011>.  
6  
7  
8  
9  
10 (30) Kim, S.; Jeong, H. Y.; Kim, S. K.; Choi, S. Y.; Lee, K. J. Flexible Memristive Memory Array on  
11 Plastic Substrates. *Nano Lett.* **2011**, 11 (12), 5438–5442.  
12  
13 <https://doi.org/10.1021/nl203206h>.  
14  
15  
16  
17 (31) Wouters, D. J.; Waser, R.; Wuttig, M. Phase-Change and Redox-Based Resistive Switching  
18 Memories. *Proc. IEEE* **2015**, 103 (8), 1274–1288.  
19  
20 <https://doi.org/10.1109/JPROC.2015.2433311>.  
21  
22  
23  
24 (32) Pham, H. H.; Wang, L. W. Oxygen Vacancy and Hole Conduction in Amorphous TiO<sub>2</sub>.  
25 *Phys. Chem. Chem. Phys.* **2015**, 17 (1), 541–550. <https://doi.org/10.1039/c4cp04209c>.  
26  
27  
28  
29 (33) Jeong, H. Y.; Lee, J. Y.; Choi, S. Y.; Kim, J. W. Microscopic Origin of Bipolar Resistive  
30 Switching of Nanoscale Titanium Oxide Thin Films. *Appl. Phys. Lett.* **2009**, 95 (16), 1–4.  
31  
32 <https://doi.org/10.1063/1.3251784>.  
33  
34  
35  
36 (34) Robertson, J. High Dielectric Constant Gate Oxides for Metal Oxide Si Transistors. *Reports*  
37 *Prog. Phys.* **2006**, 69 (2), 327–396. <https://doi.org/10.1088/0034-4885/69/2/R02>.  
38  
39  
40  
41 (35) Lanza, M.; Wong, H. S. P.; Pop, E.; Ielmini, D.; Strukov, D.; Regan, B. C.; Larcher, L.;  
42 Villena, M. A.; Yang, J. J.; Goux, L.; Belmonte, A.; Yang, Y.; Puglisi, F.M.; Kang, J.;  
43 Magyari-Köpe, B.; Yalon, E.; Kenyon, A.; Buckwell, M.; Mehonic, A.; Shluger, A.; Li, H.;  
44 Hou, T. H.; Hudec, B.; Akinwande, D.; Ge, R.; Ambrogio, S.; Roldan, J. B.; Miranda, E.;  
45 Suñe, J.; Pey, K. L.; Wu, X.; Raghavan, N.; Wu, E.; Lu, W. D.; Navarro, G.; Zhang, W.; Wu,  
46 H.; Li, R.; Holleitner, A.; Wurstbauer, U.; Lemme, M. C.; Liu, M.; Long, S.; Liu, Q.; Lv, H.;

- 1  
2  
3 Padovani, A.; Pavan, P.; Valov, I.; Jing, X.; Han, T.; Zhu, K.; Chen, S.; Hui, F.; Shi, Y.  
4  
5 Recommended Methods to Study Resistive Switching Devices. *Adv. Electron. Mater.*  
6  
7  
8 **2019**, 5 (1), 1–28. <https://doi.org/10.1002/aelm.201800143>.  
9
- (36) Takeda, Y.; Sekine, T.; Shiwaku, R.; Murase, T.; Matsui, H.; Kumaki, D.; Tokito, S. Printed  
10  
11 Organic Complementary Inverter with Single SAM Process Using a P-Type D-A Polymer  
12  
13 Semiconductor. *Appl. Sci.* **2018**, 8 (8), 1331. <https://doi.org/10.3390/app8081331>.  
14  
15  
16  
17
- (37) Hench, L. L.; Orefice, R. Sol–Gel Technology. In *Kirk-Othmer Encyclopedia of Chemical*  
18  
19 *Technology*; John Wiley & Sons, Inc.: Hoboken, NJ, USA, 2000.  
20  
21  
22 <https://doi.org/10.1002/0471238961.19151208051403.a01>.  
23  
24
- (38) Danks, A. E.; Hall, S. R.; Schnepf, Z. The Evolution of “sol-Gel” Chemistry as a Technique  
25  
26 for Materials Synthesis. *Mater. Horizons* **2016**, 3 (2), 91–112.  
27  
28  
29 <https://doi.org/10.1039/c5mh00260e>.  
30  
31
- (39) Gergel-Hackett, N.; Hamadani, B.; Dunlap, B.; Suehle, J.; Richter, C.; Hacker, C.; Gundlach,  
32  
33 D. A Flexible Solution-Processed Memristor. *IEEE Electron Device Lett.* **2009**, 30 (7), 706–  
34  
35 708. <https://doi.org/10.1109/LED.2009.2021418>.  
36  
37  
38
- (40) Abunahla, H.; Mohammad, B.; Applications, S.; Circuits, A. Synthesis and Characterization  
39  
40 of Micro-Thick TiO<sub>2</sub> and HfO<sub>2</sub> Memristors. **2018**.  
41  
42  
43
- (41) Jang, D.; Kim, D.; Moon, J. Influence of Fluid Physical Properties on Ink-Jet Printability.  
44  
45 *Langmuir* **2009**. <https://doi.org/10.1021/la900059m>.  
46  
47  
48
- (42) Li, J.; Rossignol, F.; Macdonald, J. Inkjet Printing for Biosensor Fabrication: Combining  
49  
50 Chemistry and Technology for Advanced Manufacturing. *Lab Chip* **2015**, 15 (12), 2538–  
51  
52 2558. <https://doi.org/10.1039/c5lc00235d>.  
53  
54  
55  
56  
57  
58  
59  
60

- 1  
2  
3 (43) Chuang, M. Y. Inkjet Printing of Ag Nanoparticles Using Dimatix Inkjet Printer, No 1. **2017**,  
4  
5 No. 1.  
6  
7  
8 (44) Diebold, U.; Madey, T. E. TiO<sub>2</sub> by XPS. *Surf. Sci. Spectra* **2002**.  
9  
10 <https://doi.org/10.1116/1.1247794>.  
11  
12  
13 (45) Zaroni, R.; Righini, G.; Montenero, A.; Gnappi, G.; Montesperelli, G.; Traversa, E.;  
14  
15 Gusmano, G. XPS Analysis of Sol-gel Processed Doped and Undoped TiO<sub>2</sub> Films for  
16  
17 Sensors. *Surf. Interface Anal.* **1994**. <https://doi.org/10.1002/sia.740220182>.  
18  
19  
20 (46) Prusakova, V.; Collini, C.; Nardi, M.; Tatti, R.; Lunelli, L.; Vanzetti, L.; Lorenzelli, L.; Baldi,  
21  
22 G.; Chiappini, A.; Chiasera, A.; Ristic, D.; Verucchi, R.; Bortolotti, M.; Dirè, S. The  
23  
24 Development of Sol-Gel Derived TiO<sub>2</sub> thin Films and Corresponding Memristor  
25  
26 Architectures. *RSC Adv.* **2017**, 7 (3), 1654–1663. <https://doi.org/10.1039/c6ra25618j>.  
27  
28  
29  
30 (47) Gale, E. TiO<sub>2</sub>-Based Memristors and ReRAM: Materials, Mechanisms and Models (a  
31  
32 Review). *Semicond. Sci. Technol.* **2014**, 29 (10). [https://doi.org/10.1088/0268-](https://doi.org/10.1088/0268-1242/29/10/104004)  
33  
34 [1242/29/10/104004](https://doi.org/10.1088/0268-1242/29/10/104004).  
35  
36  
37 (48) Thompson, W. A.; Perier, C.; Maroto-Valer, M. M. Systematic Study of Sol-Gel Parameters  
38  
39 on TiO<sub>2</sub> Coating for CO<sub>2</sub> Photoreduction. *Appl. Catal. B Environ.* **2018**, 238 (March), 136–  
40  
41 146. <https://doi.org/10.1016/j.apcatb.2018.07.018>.  
42  
43  
44 (49) Dongale, T. D.; Desai, N. D.; Khot, K. V.; Volos, C. K.; Bhosale, P. N.; Kamat, R. K. An  
45  
46 Electronic Synapse Device Based on TiO<sub>2</sub> Thin Film Memristor. *J. Nanoelectron.*  
47  
48 *Optoelectron.* **2018**, 13 (1), 68–75. <https://doi.org/10.1166/jno.2018.2297>.  
49  
50  
51 (50) Zapka, W. *Handbook of Industrial Inkjet Printing: A Full System Approach*; 2017; Vol. 1–2.  
52  
53 <https://doi.org/10.1002/9783527687169>.  
54  
55  
56  
57  
58  
59  
60

- 1  
2  
3 (51) Rubin, D. C.; Hinton, S.; Wenzel, A. The Precise Time Course of Retention. *J. Exp. Psychol.*  
4  
5 *Learn. Mem. Cogn.* **1999**, *25* (5), 1161–1176. <https://doi.org/10.1037/0278->  
6  
7 7393.25.5.1161.  
8  
9  
10 (52) Kwan, A. C.; Dietz, S. B.; Zhong, G.; Harris-Warrick, R. M.; Webb, W. W. Spatiotemporal  
11  
12 Dynamics of Rhythmic Spinal Interneurons Measured With Two-Photon Calcium Imaging  
13  
14 and Coherence Analysis. *J. Neurophysiol.* **2010**, *104* (6), 3323–3333.  
15  
16 <https://doi.org/10.1152/jn.00679.2010>.  
17  
18  
19 (53) Hubbard, J. I. Repetitive Stimulation at the Mammalian Neuromuscular Junction, and the  
20  
21 Mobilization of Transmitter. *J. Physiol.* **1963**, *169* (3), 641–662.  
22  
23 <https://doi.org/10.1113/jphysiol.1963.sp007286>.  
24  
25  
26 (54) Zucker, R. S. Short-Term Synaptic Plasticity. *Ann. Rev. Neurosci.* **1989**, *12*, 13–31.  
27  
28  
29 (55) Zucker, R. S.; Regehr, W. G. Short-Term Synaptic Plasticity. *Annu. Rev. Physiol.* **2002**, *8* (4),  
30  
31 355–405. <https://doi.org/10.1146/annurev.physiol.64.092501.114547>.  
32  
33  
34 (56) Del Castillo, J.; Katz, B. Statistical Factors Involved in Neuromuscular Facilitation and  
35  
36 Depression. *J. Physiol.* **1954**, No. 124, 574–585.  
37  
38  
39 (57) Uenuma, M.; Ishikawa, Y.; Uraoka, Y. Joule Heating Effect in Nonpolar and Bipolar  
40  
41 Resistive Random Access Memory. *Appl. Phys. Lett.* **2015**, *107* (7).  
42  
43 <https://doi.org/10.1063/1.4928661>.  
44  
45  
46 (58) Niu, G.; Calka, P.; Auf der Maur, M.; Santoni, F.; Guha, S.; Frasccke, M.; Hamoumou, P.;  
47  
48 Gautier, B.; Perez, E.; Walczyk, C.; Wenger, C.; Di Carlo, A.; Alff, L.; Schroeder, T.  
49  
50 Geometric Conductive Filament Confinement by Nanotips for Resistive Switching of  
51  
52 HfO<sub>2</sub>-RRAM Devices with High Performance. *Sci. Rep.* **2016**, *6*, 25757.  
53  
54  
55  
56  
57  
58  
59  
60

- 1  
2  
3 <https://doi.org/10.1038/srep25757>.
- 4  
5  
6 (59) Yu, S.; Guan, X.; Wong, H. S. P. Understanding Metal Oxide RRAM Current Overshoot and  
7 Reliability Using Kinetic Monte Carlo Simulation. *Tech. Dig. - Int. Electron Devices Meet.*  
8 *IEDM 2012*, 585–588. <https://doi.org/10.1109/IEDM.2012.6479105>.  
9  
10  
11  
12 (60) Yu, S.; Wu, Y.; Jeyasingh, R.; Kuzum, D.; Wong, H. S. P. An Electronic Synapse Device  
13 Based on Metal Oxide Resistive Switching Memory for Neuromorphic Computation. *IEEE*  
14 *Trans. Electron Devices* **2011**, *58* (8), 2729–2737.  
15  
16  
17 <https://doi.org/10.1109/TED.2011.2147791>.  
18  
19  
20  
21 (61) Bi, G.; Poo, M. Synaptic Modifications in Cultured Hippocampal Neurons: Dependence on  
22 Spike Timing, Synaptic Strength, and Postsynaptic Cell Type. *J. Neurosci.* **1998**, *18* (24),  
23 10464–10472. <https://doi.org/10.1523/JNEUROSCI.18-24-10464.1998>.  
24  
25  
26  
27 (62) Abraham, W. C.; Bear, M. F. Metaplasticity: The Plasticity of Synaptic Plasticity. *Trends*  
28 *Neurosci.* **1996**, *19* (4), 126–130. [https://doi.org/10.1016/S0166-2236\(96\)80018-X](https://doi.org/10.1016/S0166-2236(96)80018-X).  
29  
30  
31  
32 (63) Abraham, W. C.; Bear, M. F. Metaplasticity : Plasticity of Synaptic. *Trends Neurosci* **1996**,  
33 *19*, 126–130.  
34  
35  
36  
37 (64) Abbott, L. F.; Regehr, W. G. Synaptic Computation. *Nature* **2004**, *431* (7010), 796–803.  
38  
39  
40  
41 <https://doi.org/10.1038/nature03010>.  
42  
43  
44 (65) Vogels, T. P.; Froemke, R. C.; Doyon, N.; Gilson, M.; Haas, J. S.; Liu, R.; Maffei, A.; Miller,  
45 P.; Wierenga, C. J.; Woodin, M. A.; Zenke, F.; Sprekeler, H. Inhibitory Synaptic Plasticity:  
46 Spike Timing-Dependence and Putative Network Function. *Front. Neural Circuits* **2013**, *7*  
47 (July), 1–11. <https://doi.org/10.3389/fncir.2013.00119>.  
48  
49  
50  
51  
52 (66) Tao, D.; Chen, J.; Jiang, Z.; Qi, B.; Zhang, K.; Wang, W. Making Reversible Transformation  
53  
54  
55  
56  
57  
58  
59  
60

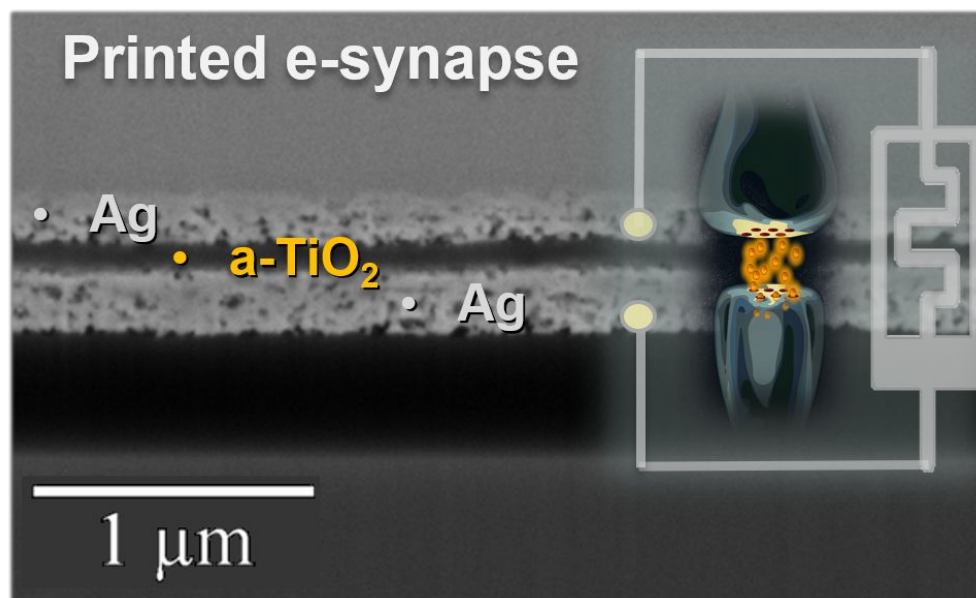


1  
2  
3 from Electronic to Ionic Resistive Switching Possible by Applied Electric Field in an  
4 Asymmetrical Al/TiO<sub>2</sub>/FTO Nanostructure. *Appl. Surf. Sci.* **2019**, 144124.

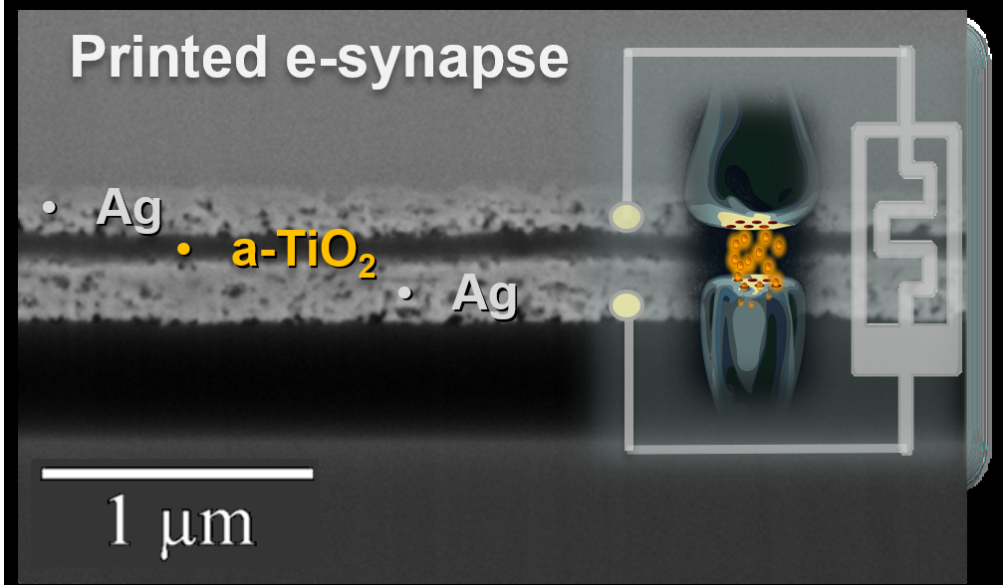
5  
6  
7  
8 <https://doi.org/10.1016/j.apsusc.2019.144124>.

- 9  
10 (67) Waser, R.; Aono, M. <nmat2023 Nanoionics-Based Resistive Switching Memories.Pdf>.  
11  
12  
13 **2007**, 833–840. <https://doi.org/10.1038/nmat2023>.

### TOC Graphic



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TOC Graphic

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